

PCM-LN02

Rev.A0.2

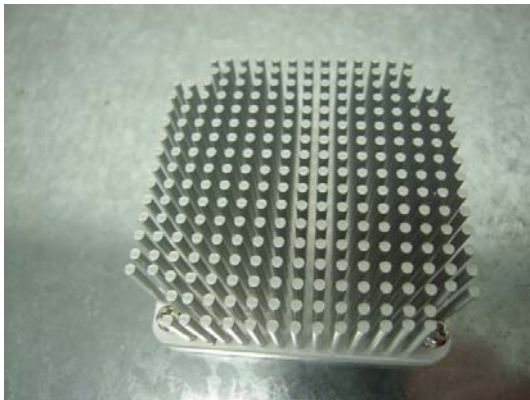
Thermal Image Analysis Report

Summary	<input checked="" type="checkbox"/> Pass			
	<input type="checkbox"/> Fail			
<input type="checkbox"/> Pass with Deviation				
Comment: _____				
Test Result Summary				
	Critical	Major	Minor	Enhancement
Defect Found	0	0	0	0
Defect Unsolved	0	0	0	0

Issue date	Approval	Test Engineer
2011 / 07 / 04	Jansin Lee	Clement Chien

Sample Configuration & Quantity Under Test

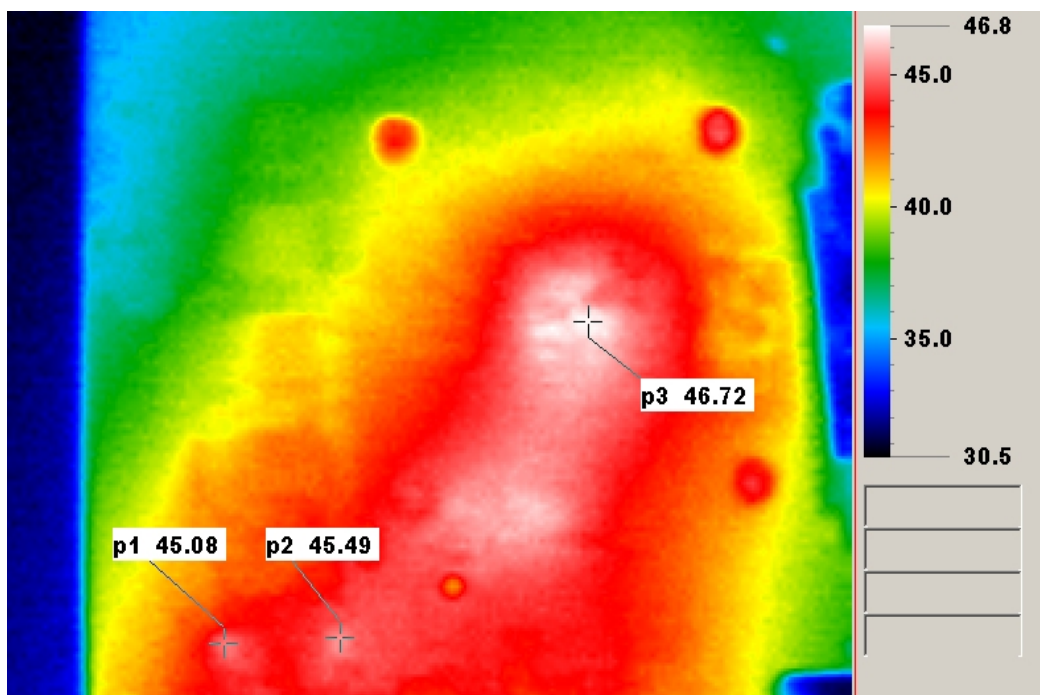
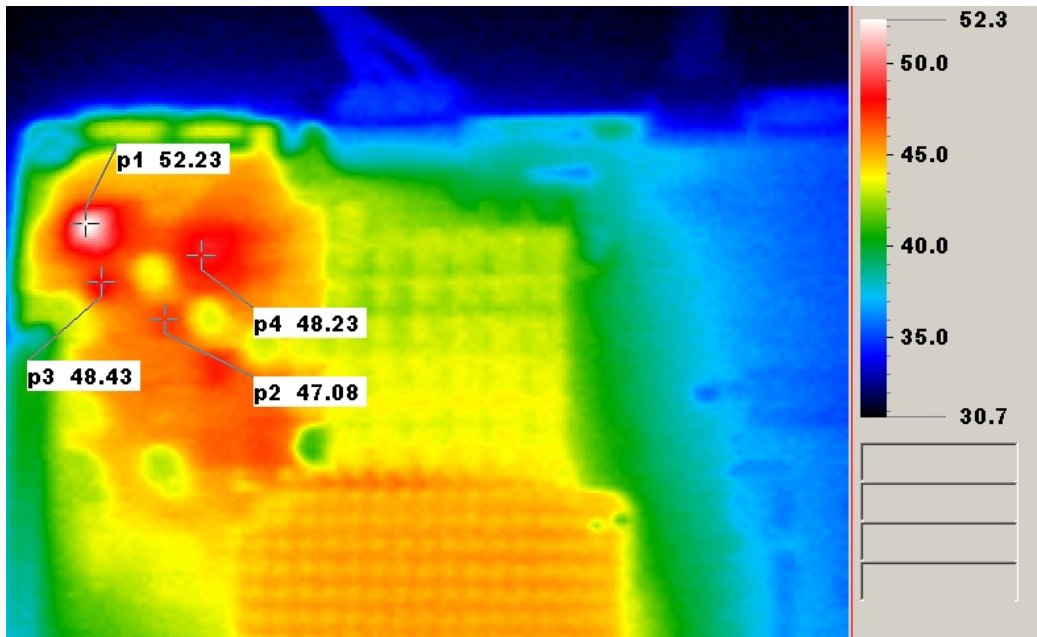
- **Model name : PCM-LN02 A0.2**
- **CPU Board : PCM-LN02 A0.2**
- **CPU : On board Intel Atom N455 / 1.66GHz**
- **Memory : On board DDR3-667 2GB**
- **HDD : Seagate 2.5" SATA ST9120823AS 120GB**
- **BIOS : PLN02 0.11**
- **Test Software : Windows XP sp3 / Run Prime95 v25.6.2**
- **Power : AT Power**
- **Heat Sink:**

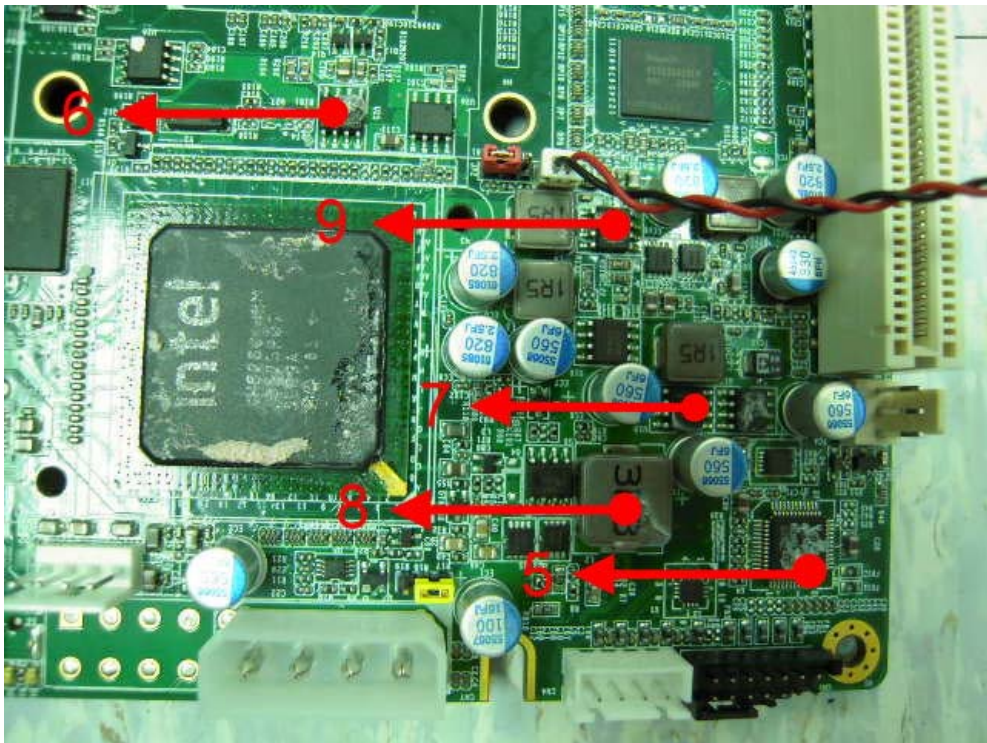
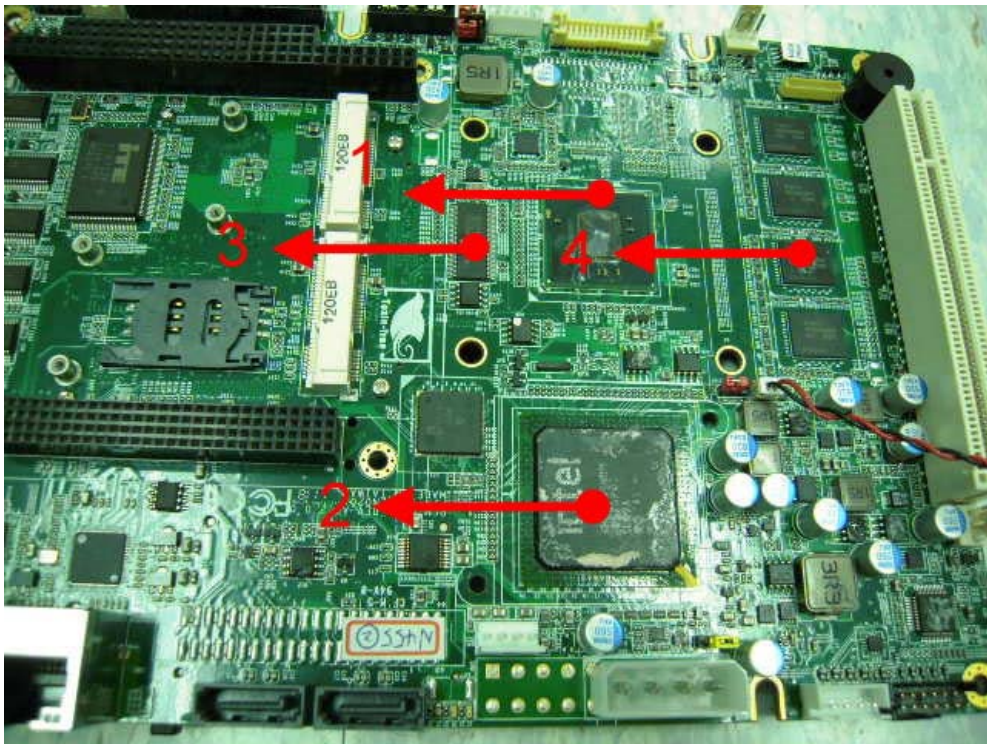


Thermal Image Analysis

1. Test Date: 2011-07-01
2. Test Product : PCM-LN02 A0.2
3. Test Site: AAEON Internal Lab.
4. Temperature Measurement:
 1. YOKOGAWA / DARWIN DA100-100-13-1D
 2. IR Scanner: Infrared Camera
NIPPON AVIONICS CO., LTD.
Model: TVS-100
Date of Calibration: 2010/08/10
Serial Number: 0179L2746
5. Test Condition:
Component Side-1 (Test by DA-100): 25.0°C With heat sink
6. Take Picture Time:
After power on 2 hours

Temperature Profile Test:





Using YOKOGAWA / DARWIN DA100-100-13-1D test

Point	Position	Describe	Tc (*1) (°C)	Tm (*2) Measured Under		Note
				25°C	60°C	
1	U35	(TF)Intel CPU.Pinetrail M.SINGLE CORE.N455.1.66GHz	100	54.2	89.2	
2	U17	(TF)Chipset ICH8M.INTEL.NH82801HBM.SLB9A	105	52.5	87.5	
3	U33	(TF)CLOCK GENERATOR.IDT.9LPRS501PGLF	115	62.8	97.8	
4	U32	(TF)DDRIII-SDRAM.256M.Hynix.H5TQ2G83BFR-H9C	95	47.6	82.6	
5	U4	(TF)Audio Codec.REALTEK.ALC662-GR	100.5	55.4	90.4	
6	U25	(TF)Regulator.Adj(1.2~4.8V).SEMTECH.SC1565IS-TRT	125	58.3	93.3	
7	U18	(TF)P-Channel MOSFET.ANPEC.APM4463KC-TRL	125	56.1	91.1	
8	L2	(TF)COIL.3.3uH.20%.ZenithTek.ZPWM-1040MB-3R3M	125	55.9	90.9	
9	U22	(TF)N-Channel.APEC.AP4224GM	125	57.5	92.5	

Note(*):

1. "Tc" indicates the component's case maximum temperature value specified in its datasheet.
2. "Tm" indicates the measured Tc value under working environmental temperature within product specification.

3. Judgment Criteria:

- **Fail** : $T_m > T_c + 5^{\circ}\text{C}$; The measured value is over specification plus margin.
- **Margin** : $T_c + 5^{\circ}\text{C} > T_m > T_c - 10^{\circ}\text{C}$; The measured value is within specification with margin.
For FANLESS system application, it is strongly recommended to add thermal dissipation design for better reliability.
- **Pass** : $T_m < T_c - 10^{\circ}\text{C}$; The measured value is with safety margin.